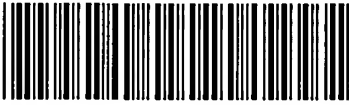


**Search Notes**

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10/644,598

Examiner

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Applicant(s)/Patent under  
Reexamination

NGUYEN ET AL.

Art Unit

3753

**SEARCHED**

Class	Subclass	Date	Examiner
UPDATED	SEARCH	11/13/2006	KL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search (US-PGPUB)	11/13/2006	KL